

April 19, 1996

CRITICAL ITEMS LIST

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1) CIL ITEM : F200-BQ-01
 2) FMEA CODE : F200-BQ
 3) COMPONENT : 28 VDC POWER INTERFACE
 4) PART NUMBER : RE1493
 5) SYSTEM/SUBSYSTEM : CONTROLLER/F200-KK
 6) FAILURE MODE : FAILURE OF THE 28 VDC INTERFACE

7) PREPARED : SSME RELIABILITY
 8) APPROVED :
 9) DATE : 04-19-96
 10) REVISION/CHANGE : -001/D
 11) EFFECTIVITY : -05
 12) HAZARD REFERENCE : SEE LISTINGS BELOW
 13) CCBD # : ME3-DI 3285

PHASE	FAILURE DESCRIPTION/EFFECT	CRITICALITY
H 4-2	<p>LOSS OR DEGRADATION OF BOTH 28 VDC SUPPLIES WILL NEGATE BOTH DCU CHANNELS FROM A NORMALLY RECOVERABLE PRIMARY POWER TRANSIENTS, CONTROLLER HALT PNEUMATIC ENGINE SHUTDOWN (SEE OPERATIONAL USE). MISSION ABORT.</p> <p>REDUNDANCY SCREENS: CONTROLLER SYSTEM: LIKE REDUNDANCY</p> <p>-----</p> <p>A: PASS. REDUNDANT HARDWARE ITEMS ARE CAPABLE OF CHECKOUT DURING NORMAL GROUND TURNAROUND. B: FAIL. LOSS OF A REDUNDANT HARDWARE ITEM IS NOT DETECTABLE DURING FLIGHT. C: PASS. LOSS OF REDUNDANT HARDWARE ITEMS COULD NOT RESULT FROM A SINGLE CREDIBLE EVENT.</p>	<p>1R HAZARD REF: NE-G4N NE-G9PS,A,B,C,D</p>

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CCL ITEM: F200-80-01	DESIGN	DOCUMENT REF.
FAILURE CAUSE A: POWER SUPPLY ELECTRONICS (1)	THE CONTROLLER CONTAINS REDUNDANT 28 VDC POWER INTERFACES (1). A HALT OF BOTH DCU'S (MULTIPLE FAILURE) RESULTS IN A CONTROLLER INITIATED PNEUMATIC SHUTDOWN (2). THE PROPER DCU/POWER SUPPLY OPERATIONS ARE VERIFIED ON A CONTINUOUS BASIS DURING CONTROLLER SELF TEST. THE CONTROLLER (WITH SOFTWARE) IS CONFIGURED TO IMPLEMENT THE APPROPRIATE REDUNDANCY MANAGEMENT RESPONSE, AND COMMAND FAIL/OPERATE OR A SAFE ENGINE STATE WHEN CONTROLLER REDUNDANCY IS LOST (2).	(1) HONEYWELL BLOCK II FMEA VOL VI (1) DSHG8977A1 (2) CP406R0008 3.1.3:1 3.2.1 3.2.3:2 3.2.3:3 3.2.4
ELECTRICAL, MECHANICAL, AND ELECTROMECHANICAL PARTS FOR THE CIRCUITS INVOLVED IN THIS FUNCTION HAVE BEEN SELECTED FROM THE CLASS 5 OR EQUIVALENT APPROVED PARTS SELECTION LIST (1), QUALITY ASSURANCE AND SCREENING REQUIREMENTS FOR HIGH RELIABILITY MICROCIRCUITS (2), AND THE SPECIFICATION CONTROL DRAWING FOR MICROCIRCUITS, MONOLITHIC SILICON, AND TRANSISTOR-TRANSISTOR LOGIC (TTL) FAMILY OF DEVICES (3). PRIOR TO INSTALLATION ON THE CARD ASSEMBLIES, COMPONENTS ARE SUBJECTED TO A BURN-IN PERIOD WHERE PARTS ARE EXERCISED AT TEMPERATURES IN EXCESS OF NORMAL CONTROLLER OPERATING ENVIRONMENT, BUT LESS THAN COMPONENT MAXIMUM SPECIFIED OPERATING ENVIRONMENT, TO SCREEN FOR INFANT MORTALITY (4). IN ADDITION TO THESE REQUIREMENTS, ALL COMPONENTS ARE DERATED FROM THE MAXIMUM RATING AT OPERATING EXTREMES (5). CLEANLINESS AND ALL PROCESSES USED DURING MANUFACTURE ARE CONTROLLED BY SPECIFICATION REQUIREMENTS (5).	THE CONTROLLER DESIGN MEETS ALL CEI FAIL-OPERATE/FAILSAFE REQUIREMENTS FOR THIS FAILURE MODE (1). REDUNDANT CONTROLLER CHANNEL FUNCTIONS ARE PHYSICALLY SEPARATED WITHIN THE CONTROLLER HOUSING (2). CIRCUITS ARE DESIGNED TO PREVENT BRIDGING (2), ALL EEE PARTS ARE REQUIRED TO HAVE CONFORMAL COATING, AND INTERNAL WIRING IS INSULATED TO PREVENT SHORT CIRCUITS FROM CONDUCTIVE CONTAMINATION (3). ALL ELECTRICAL COMPONENTS ARE CONTAINED WITHIN THE CASE STRUCTURE WHICH IS PRESSURIZED WITH A POSITIVE PRESSURE INERT GAS BACKFILL TO PREVENT CONTAMINATION (2). WHERE APPLICABLE, ELECTROMAGNETIC INTERFERENCE SHIELDING IS PROVIDED AND CIRCUIT INTERCONNECTS USE TWISTED PAIR WIRING (2). ALL CIRCUIT CARDS ARE KEYED TO THEIR RESPECTIVE CONNECTION LOCATIONS TO PRECLUDE IMPROPER INSTALLATION (2). RAMP CLAMPS ARE UTILIZED TO PRECLUDE VIBRATION INDUCED CARD FAILURES (2). DESIGN OF CIRCUIT CARDS AND DETERMINATION OF COPPER PATH TRACE SPACING, WEIGHT, AND WIDTH IS CONTROLLED BY SPECIFICATION (2). EACH UNIT (PRODUCTION AND RECYCLE) IS REQUIRED TO PASS A FUNCTIONAL ACCEPTANCE TEST UNDER ENVIRONMENTAL CONDITIONS BEYOND THOSE SEEN DURING NORMAL FIELD OPERATION WITHOUT DEGRADATION OF HARDWARE LIFE EXPECTANCY (2). A WORST CASE CIRCUIT ANALYSIS WAS PERFORMED TO VERIFY NOMINAL OPERATION AT SPECIFICATION LIMITS (4). AN ANALYSIS WAS PERFORMED BY HONEYWELL TO ASSURE NO SINGLE POINT COMPONENT FAILURES ARE INHERENT TO THE CONTROLLER DESIGN (5).	(1) 85M03928, 85M03929 (2) 85M02704 (3) 85M03766 (4) 85M03876 (5) DSHG8977A1 (1) CP320R00038 (2) DSHG8977A1 (3) 85M03928 (4) ES26472-01 (5) HONEYWELL BLOCK II FMEA VOL I

CIL ITEM: F200-80-01

DESIGN

DOCUMENT REF.

DESIGN QUALIFICATION TESTING OF THE CONTROLLER ASSEMBLY HAS BEEN PERFORMED INCLUDING: FAULT INSERTION TESTING (1), ASSEMBLY THERMAL CYCLING (2), CASE AND ASSEMBLY VIBRATION TESTING (3), ELECTROMAGNETIC INTERFERENCE AND SUSCEPTIBILITY TESTING (4), ACOUSTICAL NOISE TESTING (5), CASE ULTIMATE PRESSURE TESTING (6), AND ASSEMBLY BREAK OPEN INSPECTION (7).

- (1) TR34079282
- TR34080202
- TR34088258
- TR34088259
- (2) TR34080203
- TR34080207
- (3) TR34080204
- TR34080205
- TR34080206
- TR34087499
- (4) TR34080209
- (5) TR34080210
- (6) TR34085021
- (7) TR34085022

CIL ITEM: F200-80-01

INSPECTION AND TEST

POSSIBLE CAUSES	SIGNIFICANT CHARACTERISTICS	INSPECTION(S)/TEST(S)	DOCUMENT REF.
FAILURE CAUSE A:	RE1493 - CONTROLLER		RE1493
	ASSEMBLY INTEGRITY	CLEANLINESS REQUIREMENTS ARE VERIFIED PER SPECIFICATION DURING MANUFACTURING OF THE CONTROLLER ASSEMBLY.	RC1493
		ENVIRONMENT CONTROLS (TEMPERATURE, HUMIDITY) ARE ENFORCED DURING ASSEMBLY AND TESTING PER SPECIFICATION REQUIREMENTS.	DSHG8977A1
		TO PREVENT COMPONENT DAMAGE, STATIC ELECTRICAL DISCHARGE POTENTIAL IS CONTROLLED DURING MANUFACTURING PER SPECIFICATION REQUIREMENTS.	DSHG8977A1
	MATERIAL INTEGRITY	MATERIAL INTEGRITY IS VERIFIED PER SPECIFICATION REQUIREMENTS.	RC1493

CICL ITEM: F200-BQ-01		INSPECTION AND TEST	
POSSIBLE CAUSES	SIGNIFICANT CHARACTERISTICS	INSPECTION(S)/TEST(S)	DOCUMENT REF.
		PROTECTIVE FINISHES AND MATERIAL SELECTION TO PREVENT DETRIMENTAL EFFECTS FROM ENVIRONMENTAL EXPOSURE, STRESS CORROSION, AND ELECTROLYTIC CORROSION ARE VERIFIED PER SPECIFICATION REQUIREMENTS.	RC1493 MSFC-SPEC-250
		FLAMMABILITY REQUIREMENTS ARE VERIFIED PER SPECIFICATION REQUIREMENTS.	RC1493
	INTEGRITY OF ELECTRONICS	THE FOLLOWING PROCESSES ARE VERIFIED PER SPECIFICATION DURING MANUFACTURING OF THE CARD ASSEMBLIES: <ul style="list-style-type: none"> - CONSTRUCTION OF PRINTED CIRCUIT BOARDS. - INSTALLATION OF TERMINALS. - PLASTICS AND ELASTOMERS FOR ELECTRONIC ENCAPSULATION. - SOLDERED ELECTRICAL CONNECTIONS. - POST-SOLDERING INSPECTION FREE OF SPLATTER AND CONTAMINATION. - ELECTRICAL BONDING. - COMPONENT LEAD AND INTERCONNECTION MATERIAL SELECTION. - FREE OF CONTAMINATION AFTER CONFORMAL COATING. 	RL10005 RL10007 RL10008 RL10009 RL10009 RC1493 BSN03928 RC1493
	WELD INTEGRITY	ALL WELDS ARE VERIFIED TO DRAWING AND SPECIFICATION REQUIREMENTS.	RL10011
	PRE-CLOSEOUT TESTING AND INSPECTION	THE FOLLOWING TESTS ARE PERFORMED AT THE CARD/COMPONENT LEVEL DURING MANUFACTURING: <ul style="list-style-type: none"> - PARTIAL IMPACT NOISE DETECTION (PIND) TEST ON HYBRID MICROCIRCUITS AND CAVITY TYPE DEVICES. - ULTRASONIC SCAN TEST FOR DELAMINATION CERAMIC ON CAPACITORS (CKN05 AND CER06). - BURN-IN PERIOD FOR ELECTRICAL PARTS. - INSULATION RESISTANCE AND CONTINUITY TEST. - DIELECTRIC WITHSTANDING VOLTAGE. - FUNCTIONAL TEST. - K-RAY OF CONTROLLER INTERNAL CABLES AND WIRES. 	DSHG8977A1 DSHG8977A1 BSN03928 DSHG8977A1 DSHG8977A1 DSHG8977A1 DSHG8977A1

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CIL ITEM: F200-09-01		INSPECTION AND TEST	
POSSIBLE CAUSES	SIGNIFICANT CHARACTERISTICS	INSPECTION(S)/TEST(S)	DOCUMENT REF.
		<p>THE FOLLOWING INSPECTIONS ARE PERFORMED ON THE COMPLETED ASSEMBLY PRIOR TO FINAL CLOSURE:</p> <ul style="list-style-type: none"> - INTERNAL AND EXTERNAL CLEANLINESS. - CARD DIMENSIONS ARE VERIFIED AT CARD ASSEMBLY. - CHASSIS CAVITY INSPECTION FOR CONTAMINATION. - ELECTRICAL INTERFACE CONNECTORS. - CARD INSTALLATION AND CONFIGURATION AUDIT. - CONFORMAL COATING OF EEE PARTS. 	<p>RC1493 DSHC8977A1 RC1493 RC1493 DSHC8977A1 BSMC3928</p>
	ACCEPTANCE TESTS	<p>THE FOLLOWING TESTS ARE PERFORMED BY HOMEWELL DURING ACCEPTANCE TESTING:</p> <ul style="list-style-type: none"> - HERMETIC SEAL AND PRESSURIZATION PORT LEAK TEST. - FUNCTIONAL TEST INCLUDING: <ul style="list-style-type: none"> - OUTPUT INTERFACE, - CHECKOUT, - OPERATION, - CONTROLLER CHECKOUT. - HIGH TEMPERATURE OPERATION. - LOW TEMPERATURE OPERATION. - VIBRATION TESTING. - FINAL FUNCTIONAL TEST. 	<p>RC1493 RC1493 RC1493 RC1493 RC1493 RC1493 RC1493 RC1493 RC1493</p>
	NOT FIRE ACCEPTANCE TESTING (GREEN RUN)	CONTROLLER OPERATION IS VERIFIED THROUGH ENGINE NOT FIRE ACCEPTANCE TESTING.	FL00461
	HERMETIC SEAL INTEGRITY	INTERNAL PRESSURE IS MONITORED DURING CONTROLLER OPERATION.	OMRSD V41AND.040
	FLIGHT FLOW TESTING	<p>THE FOLLOWING TESTS ARE PERFORMED DURING FLIGHT FLOW VEHICLE PROCESSING AND AFTER ANY MAINTENANCE OR REPLACEMENT:</p> <ul style="list-style-type: none"> - POWER APPLICATION AND VERIFICATION. - CONTROLLER CHECKOUT. - FLIGHT READINESS TEST. - SELF-TEST. 	<p>OMRSD V41AND.010 OMRSD V41AND.035 OMRSD V41ASD.030-A CP406R000B</p>

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CIL ITEM: F200-BQ-01		INSPECTION AND TEST	
POSSIBLE CAUSES	SIGNIFICANT CHARACTERISTICS	INSPECTION(S)/TEST(S)	DOCUMENT REF.
	PRE-FLIGHT CHECKOUT	<p>THE FOLLOWING TESTS ARE PERFORMED DURING LAUNCH COUNTDOWN:</p> <ul style="list-style-type: none"> - POWER APPLICATION AND VERIFICATION. - PRE-CRYO LOADING CHECKOUT, - SELF-TEST. <p>CONTROLLER OPERATION IS VERIFIED BY THE GROUND LAUNCH SEQUENCER PRIOR TO ENGINE START BY ACCEPTANCE OF COMMANDS PURGE SEQUENCE 4, POWER LEVEL, AND START ENABLE.</p>	<p>OMRSD S00FA0.213 OMRSD S00FA0.213 CP406R0008</p> <p>LAUNCH COMMIT CRITERIA 36E-4-1126</p>
	CONTINUOUS SELF-TEST	BITE TEST IS PERFORMED EVERY MAJOR CYCLE TO VERIFY HARDWARE INTEGRITY. (LAST TEST)	CP406R0008
<p>FAILURE HISTORY: COMPREHENSIVE FAILURE HISTORY DATA IS MAINTAINED IN THE PROBLEM REPORTING DATABASE (PRAMS/PBACA). REFERENCE: NASA LETTER SA21/88/308 AND ROCKETDYNE LETTER 88RC09761.</p>			

OPERATIONAL USE: FAILURE MODE CAN BE DETECTED IN REALTIME BY THE FLIGHT CONTROL TEAM WHO WILL EVALUATE EFFECTS UPON VEHICLE PERFORMANCE AND ABORT CAPABILITY. BASED ON THIS EVALUATION THE APPROPRIATE ABORT MODE OR SYSTEM CONFIGURATION WILL BE SELECTED. FAILURE DETECTION CUES AND ASSOCIATED SSME PERFORMANCE DATA HAVE BEEN COORDINATED BETWEEN THE ENGINEERING AND FLIGHT OPERATIONS ORGANIZATIONS WITH THE RESPONSES DOCUMENTED IN MISSION FLIGHT RULES.